

# Abstracts

## Characterization of a Class of Waveguide Discontinuities Using a Modified TE<sup>x</sup>/<sub>mn</sub> Mode Approach

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*J. Bornemann and R. Vahldieck. "Characterization of a Class of Waveguide Discontinuities Using a Modified TE<sup>x</sup>/<sub>mn</sub> Mode Approach." 1990 Transactions on Microwave Theory and Techniques 38.12 (Dec. 1990 [T-MTT] (1990 Symposium Issue)): 1816-1822.*

This paper presents a modified TE<sup>x</sup>/<sub>mn</sub> wave approach which is used in conjunction with the mode matching method for the field theory modeling of a class of waveguide discontinuities. In particular, for characterizing waveguide discontinuities in which resonant effects occur, this method resolves conflicting results which have been observed rising the conventional TE<sup>x</sup>/<sub>mn</sub> mode matching technique, commonly known from the literature, and the generalized analysis based on a linear superposition of TE<sup>z</sup>/<sub>mn</sub> and TM<sup>z</sup>/<sub>mn</sub> modes. It is found that results from the modified TE<sup>x</sup>/<sub>mn</sub> mode approach are consistent with the generalized analysis and agree well with measurements on iris filters and corrugated waveguide polarizers. In comparison with the generalized TE-TM mode analysis, the modified TE<sup>x</sup>/<sub>mn</sub> mode procedure consumes less memory and CPU time and provides improved convergence behavior without sacrificing design accuracy.

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